

N-channel 60 V, 5.2 mΩ logic level MOSFET in LFPAK56 3 June 2016 Product data sheet

#### 1. **General description**

Logic level N-channel MOSFET in an LFPAK56 (Power SO8) package using TrenchMOS technology. This product is designed and qualified for use in a wide range of power supply & motor control equipment.

#### Features and benefits 2.

- Advanced TrenchMOS provides low R<sub>DSon</sub> and low gate charge •
- Logic level gate operation
- Avalanche rated, 100% tested •
- LFPAK provides maximum power density in a Power SO8 package

#### Applications 3.

- Synchronous rectifier in LLC topology
- Chargers & adaptors with V<sub>out</sub> < 10 V •
- Fast charge & USB-PD applications •
- Battery powered motor control
- LED lighting & TV backlight

### 4. Quick reference data

| Table 1. Qui      | ck reference data                |   |     |     |      |     |      |
|-------------------|----------------------------------|---|-----|-----|------|-----|------|
| Symbol            | Parameter                        | Conditions  |     | Min | Тур  | Max | Unit |
| V <sub>DS</sub>   | drain-source voltage             | 25 °C ≤ T <sub>j</sub> ≤ 175 °C   |     | -   | -    | 60  | V    |
| I <sub>D</sub>    | drain current                    | V <sub>GS</sub> = 5 V; T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>                             | [1] | -   | -    | 100 | А    |
| P <sub>tot</sub>  | total power dissipation          | T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>  |     | -   | -    | 195 | W    |
| Static charact    | eristics                         |   |     |     |      |     |      |
| R <sub>DSon</sub> | drain-source on-state resistance | V <sub>GS</sub> = 5 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 25 °C; <u>Fig. 11</u>      |     | -   | 4.6  | 6   | mΩ   |
| Dynamic char      | acteristics                      |   |     |     |      |     |      |
| Q <sub>GD</sub>   | gate-drain charge                | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 48 V; V <sub>GS</sub> = 5 V;<br>Fig. 13; Fig. 14 |     | -   | 11.1 | -   | nC   |

[1] Continuous current is limited by package.





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### 5. Pinning information

| Table 2. | Pinning | information                       |  |                |
|----------|---------|-----------------------------------|--|----------------|
| Pin      | Symbol  | Description                       | Simplified outline                         | Graphic symbol |
| 1        | S       | source                            | mb   | D              |
| 2        | S       | source                            |  |                |
| 3        | S       | source                            | q  | G              |
| 4        | G       | gate                              | មុប្បូប្                                   | mbb076 S       |
| mb       | D       | mounting base; connected to drain | 1 2 3 4<br>LFPAK56; Power-<br>SO8 (SOT669) |                |

# 6. Ordering information

| Table 3. Ordering information |                       |  |         |  |  |  |
|-------------------------------|-----------------------|--|---------|--|--|--|
| Type number                   | Package               |  |         |  |  |  |
|                               | Name                  | Description  | Version |  |  |  |
| PSMN5R2-60YL                  | LFPAK56;<br>Power-SO8 | Plastic single-ended surface-mounted package (LFPAK56; Power-SO8); 4 leads | SOT669  |  |  |  |

# 7. Limiting values

#### Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol                  | Parameter               | Conditions   |     | Min | Max | Unit |
|-------------------------|-------------------------|--|-----|-----|-----|------|
| V <sub>DS</sub>         | drain-source voltage    | 25 °C ≤ T <sub>j</sub> ≤ 175 °C                                  |     | -   | 60  | V    |
| V <sub>DGR</sub>        | drain-gate voltage      | R <sub>GS</sub> = 20 kΩ  |     | -   | 60  | V    |
| V <sub>GS</sub>         | gate-source voltage     |  |     | -20 | 20  | V    |
| P <sub>tot</sub>        | total power dissipation | T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>                           |     | -   | 195 | W    |
| I <sub>D</sub> drain cu | drain current           | V <sub>GS</sub> = 5 V; T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>    | [1] | -   | 100 | А    |
|                         |                         | V <sub>GS</sub> = 5 V; T <sub>mb</sub> = 100 °C; <u>Fig. 2</u>   |     | -   | 85  | А    |
| I <sub>DM</sub>         | peak drain current      | pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^\circ C$ ; Fig. 3 |     | -   | 479 | А    |
| T <sub>stg</sub>        | storage temperature     |  |     | -55 | 175 | °C   |
| Tj                      | junction temperature    |  |     | -55 | 175 | °C   |
| Source-dra              | in diode                |  | 1   |     |     |      |
| I <sub>S</sub>          | source current          | T <sub>mb</sub> = 25 °C  | [1] | -   | 100 | А    |
| I <sub>SM</sub>         | peak source current     | pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$         |     | -   | 479 | А    |

[1]

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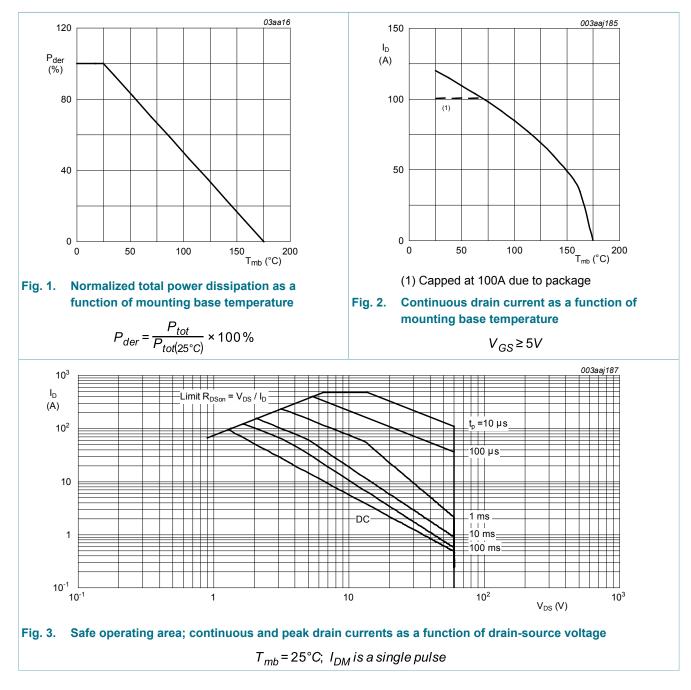
#### N-channel 60 V, 5.2 m $\Omega$ logic level MOSFET in LFPAK56

| Symbol               | Parameter                                       | Conditions  |        | Min | Мах | Unit |
|----------------------|---|---|--------|-----|-----|------|
| Avalanche ruggedness |   |   |        |     |     |      |
| E <sub>DS(AL)S</sub> | non-repetitive drain-source<br>avalanche energy | $\label{eq:ID} \begin{array}{l} I_D = 100 \text{ A}; \ V_{sup} \leq 60 \text{ V}; \ R_{GS} = 50 \ \Omega; \\ V_{GS} = 5 \text{ V}; \ T_{j(init)} = 25 \ ^\circ\text{C}; \ unclamped; \\ \hline \hline Fig. \ 4 \end{array}$ | [2][3] | -   | 127 | mJ   |

Continuous current is limited by package.

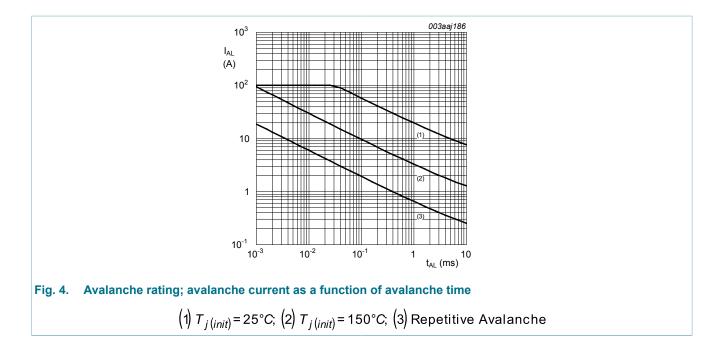
[2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

[3] Refer to application note AN10273 for further information.



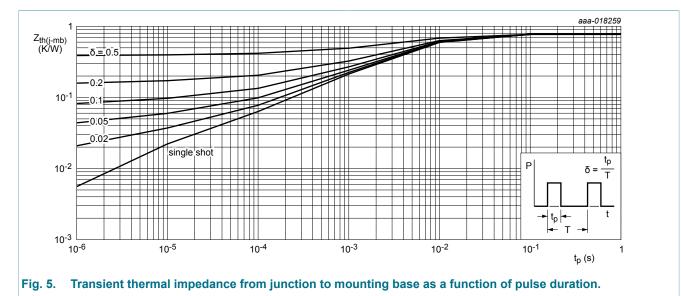
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#### N-channel 60 V, 5.2 mΩ logic level MOSFET in LFPAK56



### 8. Thermal characteristics

| Table 5. Thermal characteristics |   |               |  |     |     |      |      |
|----------------------------------|---|---------------|--|-----|-----|------|------|
| Symbol                           | Parameter   | Conditions    |  | Min | Тур | Мах  | Unit |
| R <sub>th(j-mb)</sub>            | thermal resistance<br>from junction to<br>mounting base | Fig. <u>5</u> |  | -   | -   | 0.77 | K/W  |



N-channel 60 V, 5.2 mΩ logic level MOSFET in LFPAK56

### 9. Characteristics

| Symbol               | Parameter                     | Conditions   | Min | Тур  | Max  | Unit |
|----------------------|-------------------------------|--|-----|------|------|------|
| Static chara         | acteristics                   |  |     |      |      |      |
| V <sub>(BR)DSS</sub> | drain-source                  | $I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = 25 °C  | 60  | -    | -    | V    |
|                      | breakdown voltage             | $I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = -55 °C   | 54  | -    | -    | V    |
| V <sub>GS(th)</sub>  | gate-source threshold voltage | $I_D = 1 \text{ mA}; V_{DS}=V_{GS}; T_j = 25 \text{ °C}; Fig. 9;$<br>Fig. 10                     | 1.4 | 1.7  | 2.1  | V    |
|                      |                               | I <sub>D</sub> = 1 mA; V <sub>DS</sub> =V <sub>GS</sub> ; T <sub>j</sub> = -55 °C; <u>Fig. 9</u> | -   | -    | 2.45 | V    |
|                      |                               | I <sub>D</sub> = 1 mA; V <sub>DS</sub> =V <sub>GS</sub> ; T <sub>j</sub> = 175 °C; <u>Fig. 9</u> | 0.5 | -    | -    | V    |
| I <sub>DSS</sub>     | drain leakage current         | $V_{DS}$ = 60 V; $V_{GS}$ = 0 V; $T_j$ = 175 °C  | -   | -    | 500  | μA   |
|                      |                               | $V_{DS}$ = 60 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C   | -   | 0.07 | 10   | μA   |
| I <sub>GSS</sub>     | gate leakage current          | V <sub>GS</sub> = 16 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C                            | -   | 2    | 100  | nA   |
|                      |                               | $V_{GS}$ = -16 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C  | -   | 2    | 100  | nA   |
| R <sub>DSon</sub>    | drain-source on-state         | V <sub>GS</sub> = 5 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 25 °C; <u>Fig. 11</u>             | -   | 4.6  | 6    | mΩ   |
| resis                | resistance                    | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 25 °C;<br>Fig. 11                | -   | 4    | 5.2  | mΩ   |
|                      |                               | V <sub>GS</sub> = 5 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 175 °C;<br>Fig. 11; Fig. 12       | -   | -    | 13.6 | mΩ   |
| Dynamic cł           | naracteristics                |  | I   |      |      |      |
| Q <sub>G(tot)</sub>  | total gate charge             | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 48 V; V <sub>GS</sub> = 5 V;<br>Fig. 13; Fig. 14        | -   | 39.4 | -    | nC   |
|                      |                               | I <sub>D</sub> = 25 A; V <sub>DS</sub> = 48 V; V <sub>GS</sub> = 10 V;<br>Fig. 13; Fig. 14       | -   | 78.4 | -    | nC   |
| Q <sub>GS</sub>      | gate-source charge            | $I_D$ = 25 A; $V_{DS}$ = 48 V; $V_{GS}$ = 5 V;   | -   | 12.3 | -    | nC   |
| Q <sub>GD</sub>      | gate-drain charge             | <u>Fig. 13; Fig. 14</u>  | -   | 11.1 | -    | nC   |
| C <sub>iss</sub>     | input capacitance             | $V_{DS}$ = 25 V; $V_{GS}$ = 0 V; f = 1 MHz;  | -   | 4739 | 6319 | pF   |
| C <sub>oss</sub>     | output capacitance            | T <sub>j</sub> = 25 °C; <u>Fig. 15</u>   | -   | 391  | 469  | pF   |
| C <sub>rss</sub>     | reverse transfer capacitance  |  | -   | 202  | 277  | pF   |
| t <sub>d(on)</sub>   | turn-on delay time            | $V_{DS}$ = 45 V; R <sub>L</sub> = 1.8 Ω; V <sub>GS</sub> = 5 V;                                  | -   | 24   | -    | ns   |
| t <sub>r</sub>       | rise time                     | $R_{G(ext)} = 5 \Omega$  | -   | 44   | -    | ns   |
| t <sub>d(off)</sub>  | turn-off delay time           | 1 -  | -   | 60   | -    | ns   |
| t <sub>f</sub>       | fall time                     | 1  | -   | 37   | -    | ns   |
| Source-dra           | in diode                      | ,  | I   | 1    |      |      |
| V <sub>SD</sub>      | source-drain voltage          | I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 25 °C; <u>Fig. 16</u>             | -   | 0.8  | 1.2  | V    |

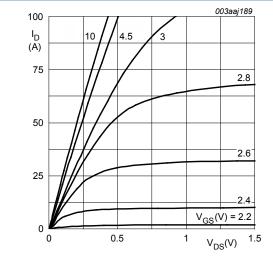
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| Symbol          | Parameter             | Conditions   | Min | Тур | Max | Unit |
|-----------------|-----------------------|--|-----|-----|-----|------|
| t <sub>rr</sub> | reverse recovery time | $I_{\rm S}$ = 20 A; dI_{\rm S}/dt = -100 A/µs; V_{\rm GS} = 0 V; | -   | 26  | -   | ns   |
| Q <sub>r</sub>  | recovered charge      | $V_{DS} = 25 V$  | -   | 23  | -   | nC   |



T<sub>j</sub> = 25 °C; t<sub>p</sub> = 300 μs



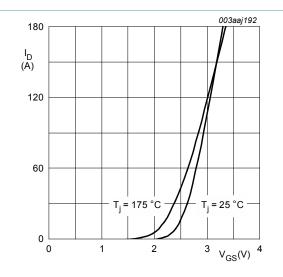


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values  $V_{DS} = 10V$ 

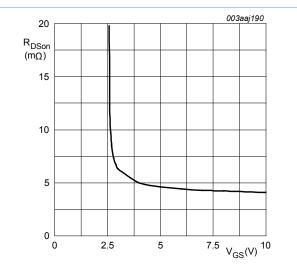


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

 $T_i = 25^{\circ}C; I_D = 25A$ 

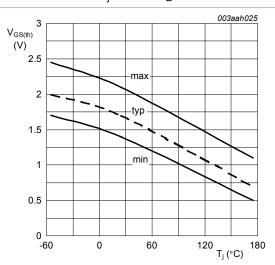
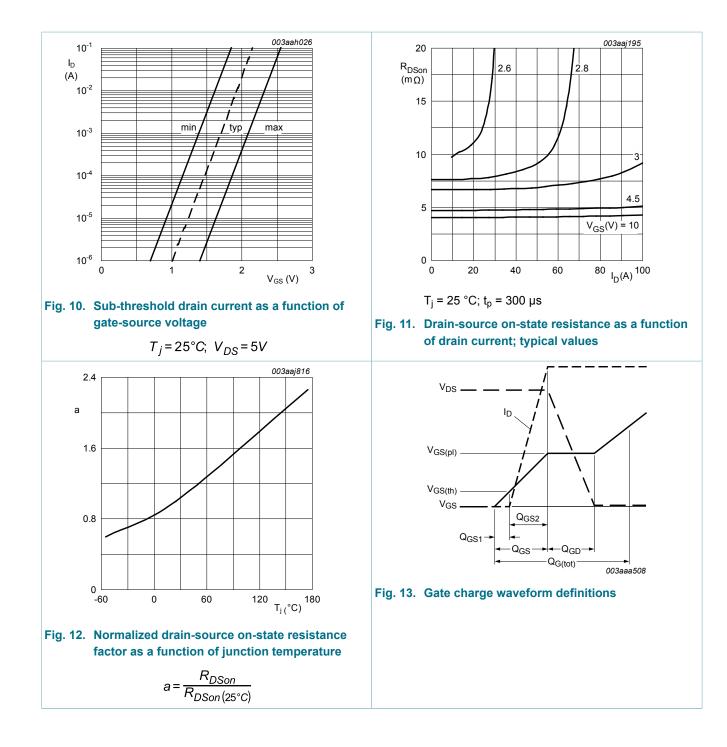


Fig. 9. Gate-source threshold voltage as a function of junction temperature

$$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$$

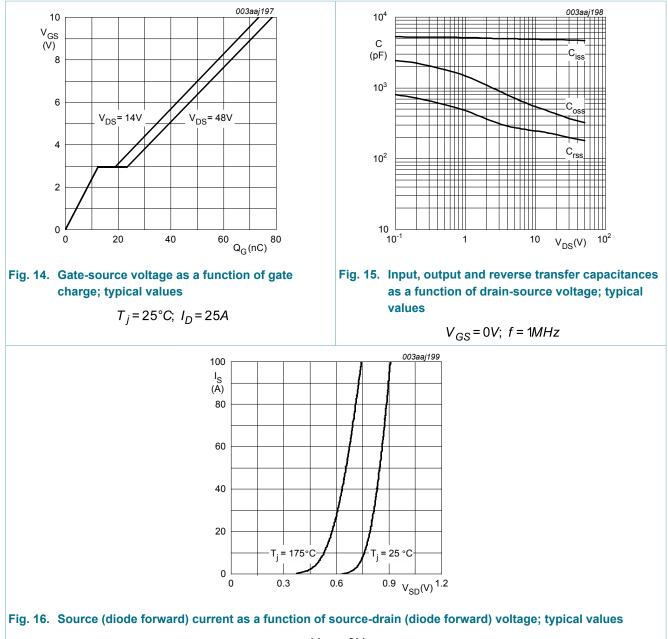
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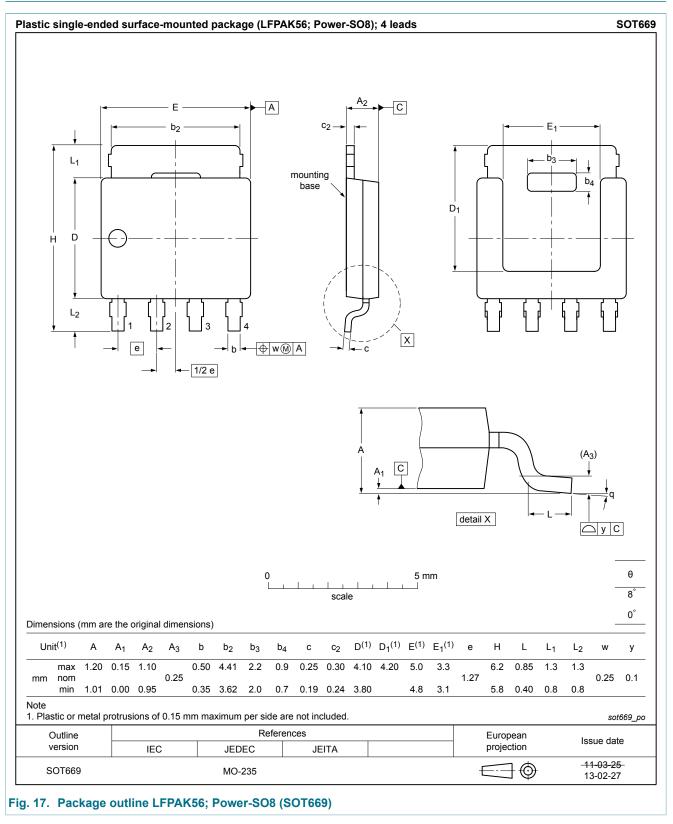
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 $V_{GS} = 0V$ 

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### 10. Package outline



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